<u>TOSHIBA</u>

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (T -MOSIV)

2SK3763

Switching Regulator Applications

- Low drain-source ON resistance: RDS (ON) = 3.7 (typ.)
- High forward transfer admittance: $|Y_{fs}| = 2.6 \text{ S}$ (typ.)
- Low leakage current: $I_{DSS} = 100 \ \mu A (V_{DS} = 720 V)$
- Enhancement-mode: $V_{th} = 2.0 \sim 4.0 V (V_{DS} = 10 V, I_D = 1 mA)$

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		V _{DSS}	900	V
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V _{DGR}	900	V
Gate-source voltage		V _{GSS}	±30	V
Drain current	DC (Note 1)	۱ _D	3	А
	Pulse (t = 1 ms) (Note 1)	l _{DP}	9	
Drain power dissipation (Tc = 25° C)		PD	69	W
Single pulse avalanche energy (Note 2)		E _{AS}	56.7	mJ
Avalanche current			ataSheet4U.c	A A
Repetitive avalanche energy (Note 3)		E _{AR}	6.9	mJ
Channel temperature		T _{ch}	150	°C
Storage temperature range		T _{stg}	-55~150	°C

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.81	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	83.3	°C/W



Note 2: $V_{DD} = 90 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}, \text{ L} = 11.6 \text{ mH}, \text{ I}_{AR} = 3.0 \text{ A}, \text{ R}_{G} = 25 \Omega$

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device. Please handle with caution.





unit : mm

Electrical Characteristics (Ta = 25°C)

Char	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		lgss	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$	—	_	±10	μΑ
Gate-source brea	akdown voltage	V (BR) GSS	$I_{G} = \pm 10 \ \mu A, \ V_{GS} = 0 \ V$	±30	_	_	V
Drain cut-off curr	ent	loss	$V_{DS} = 720 V, V_{GS} = 0 V$	_	_	100	μA
Drain-source bre	akdown voltage	V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	900	_	_	V
Gate threshold v	oltage	V _{th}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	2.0	_	4.0	V
Drain-source ON	resistance	R _{DS (ON)}	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 1.5 \text{ A}$		3.7	4.3	Ω
Forward transfer	admittance	Y _{fs}	$V_{DS} = 20 \text{ V}, \text{ I}_{D} = 1.5 \text{ A}$	0.65	2.6		S
Input capacitance		C _{iss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz		700		pF
Reverse transfer capacitance		C _{rss}			15	_	
Output capacitance		C _{oss}		_	75	—	
Switching time	Rise time	tr	V_{GS} $0 V$ V_{GS} $0 V$ $F_{L} = 1.5 A$ $R_{L} = 133 \Omega$ $V_{DD} \simeq 200 V$	_	20		
	Turn-on time	t _{on}		_	60	_	
	Fall time	t _f			35	_	ns
	Turn-off time	t _{off}	Duty \leq 1%, t _w = 10 μ s		125	_	
Total gate charge		Qg	$V_{DD}{\simeq}400$ V, $V_{GS}{=}10$ V, $I_{D}{=}3$ A	_	17	_	nC
Gate-source charge		Q _{gs}			10		
Gate-drain charge		Q _{gd}]		7		

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Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—		_	3	А
Pulse drain reverse current (Note 1)	I DRP	—	_	_	9	А
Forward voltage (diode)	V _{DSF}	$I_{DR} = 3 \text{ A}, \text{ V}_{GS} = 0 \text{ V}$	_	_	-1.9	V
Reverse recovery time	t _{rr}	$I_{DR} = 3 \text{ A}, V_{GS} = 0 \text{ V},$		850	_	ns
Reverse recovery charge	Q _{rr}	dl _{DR} /dt = 100 A/µs		4.7	_	μC

Marking



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